

	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/537,153	IKURA ET AL.	
Ī	Examiner	Art Unit	
	Trung Q. Nguyen	2829	

SEARCHED					
Class	Subclass	Date	Examiner		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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PG-PUB Search (see attached search)		1/3/2008	QΤ	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East Search Class: 324/758,760-762, 770, 158.1, 765, 750. Class: 438/14, 17. Class: 345/99, 88, 904. Class: 349/40, 150-152.	1/3/2008	QT		
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